

General Description

The WSD6056DN56 is the highest performance trench Dual N-Channel MOSFET with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The WSD6056DN56 meet the RoHS and Green Product requirement 100% E_{AS} guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% E_{AS} Guaranteed
- Green Device Available

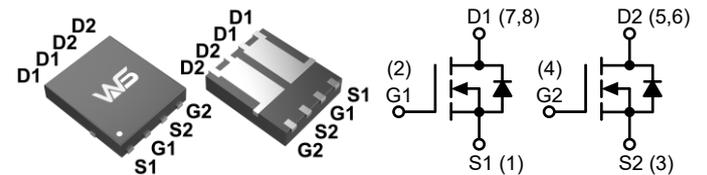
Product Summary

BV_{DSS}	$R_{DS(ON)}$	I_D
60V	16m Ω	45A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Fast switching
- Load Switch

DFN5X6-8L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter		Rating	Units
V_{DS}	Drain-Source Voltage		60	V
V_{GS}	Gate-Source Voltage		± 20	
T_J	Maximum Junction Temperature		150	$^{\circ}C$
T_{STG}	Storage Temperature Range		-55 to 150	
I_S	Diode Continuous Forward Current	$T_C=25^{\circ}C$	45	A
I_D	Continuous Drain Current	$T_C=25^{\circ}C$	45	A
		$T_C=70^{\circ}C$	28.5	
I_{DM}^b	Pulse Drain Current Tested	$T_C=25^{\circ}C$	180	A
P_D	Maximum Power Dissipation	$T_C=25^{\circ}C$	67	W
		$T_C=70^{\circ}C$	45	
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	Steady State	5	$^{\circ}C/W$
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient	$t \leq 10s$	45	$^{\circ}C/W$
		Steady State ^b	90	
I_{AS}^d	Avalanche Current, Single pulse	$L=0.5mH$	20	A
E_{AS}^d	Avalanche Energy, Single pulse	$L=0.5mH$	20	mJ

Electrical Characteristics (T_J=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Units
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	60	---	---	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V T _J =85°C	---	---	1.0 30	μA
I _{GSS}	Gate Leakage Current	V _{GS} =±25V, V _{DS} =0V	---	---	±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} , I _{DS} =250μA	1.2	1.5	2.5	V
R _{DS(ON)} ³	Drain-Source On-state Resistance	V _{GS} =10V, I _D =20A V _{GS} =4.5V, I _D =15A	---	16 20	20 25	mΩ
Diode Characteristics						
V _{SD}	Diode Forward Voltage	I _{SD} =1A, V _{GS} =0V	---	0.75	1.2	V
t _{rr}	Reverse Recovery Time	I _{SD} =20A, di _{SD} /dt=100A/μs	---	26	---	ns
Q _{rr}	Reverse Recovery Charge		---	30	---	nC
Dynamic Characteristics ^{3,4}						
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1.0MHz	---	0.9	---	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =30V, f=1.0MHz	---	945	---	pF
C _{oss}	Output Capacitance					
C _{rss}	Reverse Transfer Capacitance					
T _{d(on)}	Turn-on Delay Time	V _{DD} =30V, I _{DS} =1A V _{GEN} =10V, R _G =3.3Ω	---	10	---	ns
T _r	Turn-on Rise Time					
T _{d(off)}	Turn-off Delay Time					
T _f	Turn-on Fall Time					
Gate Charge Characteristics ^{3,4}						
Q _g	Total Gate Charge	V _{DS} =30V, V _{GS} =10V, I _{DS} =20A V _{DS} =30V, V _{GS} =10V, I _{DS} =20A	---	28	---	nC
Q _g	Total Gate Charge					
Q _{gth}	Threshold Gate Charge					
Q _{gs}	Gate-Source Charge					
Q _{gd}	Gate-Drain Charge					

Note:

- a: Max. continuous current is limited by bonding wire.
- b: Pulse width limited by max. junction temperature.
- c: Surface mounted on 1in² pad area, steady state t = 999s.
- d: UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature T_J=25°C).

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V_{DD}=48V, V_{GS}=10V, L=0.1mH, I_{AS}=20A., R_G=25Ω Starting T_J=25°C
3. The data tested by pulsed, pulse width ≤ 300μs, duty cycle ≤ 2%.
4. Essentially independent of operating temperature.

Typical Characteristics

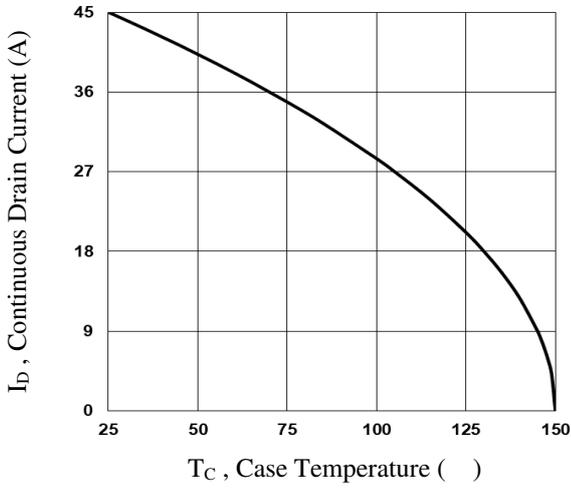


Fig.1 Continuous Drain Current vs. T_C

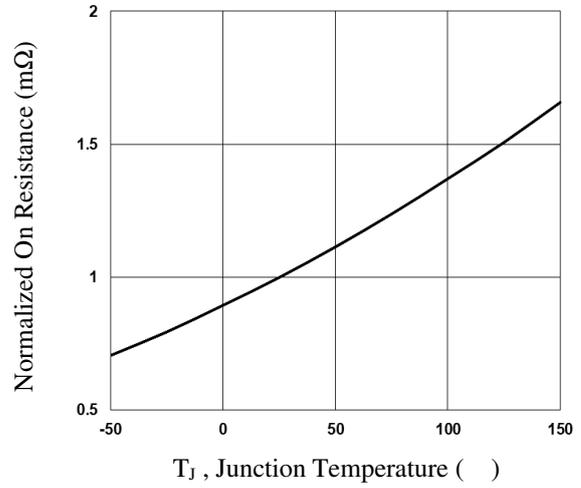


Fig.2 Normalized $R_{DS(ON)}$ vs. T_J

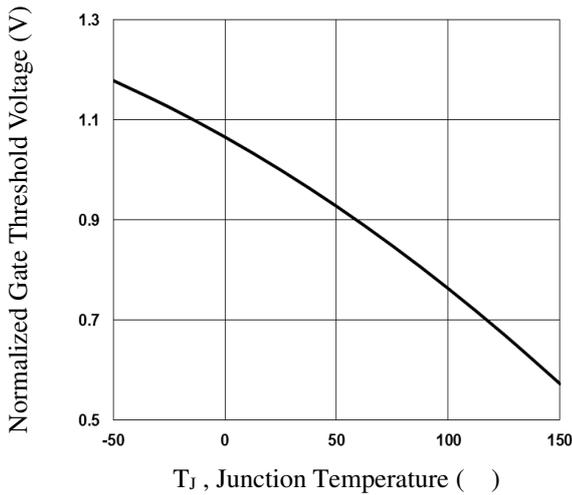


Fig.3 Normalized V_{th} vs. T_J

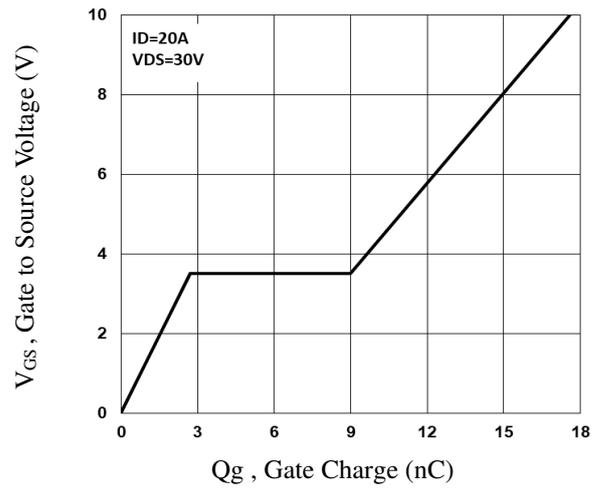


Fig.4 Gate Charge Waveform

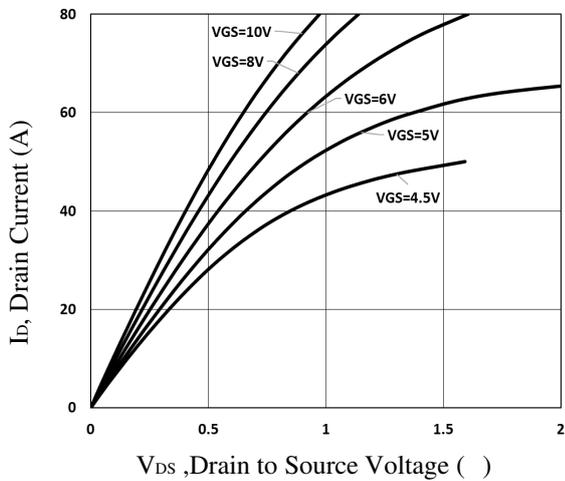


Fig.5 Typical Output Characteristics

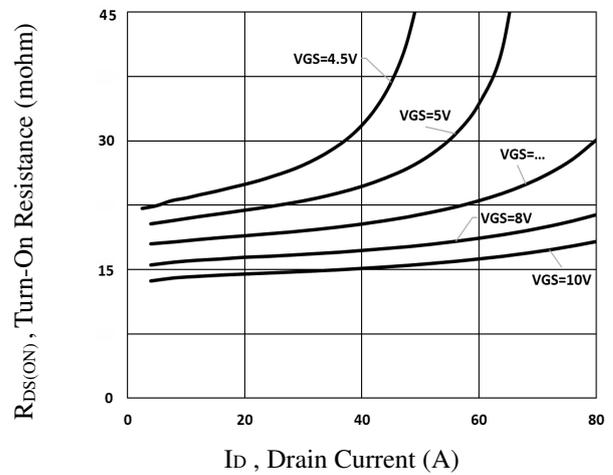


Fig.6 Turn-On Resistance vs. I_D

Typical Characteristics (Cont.)

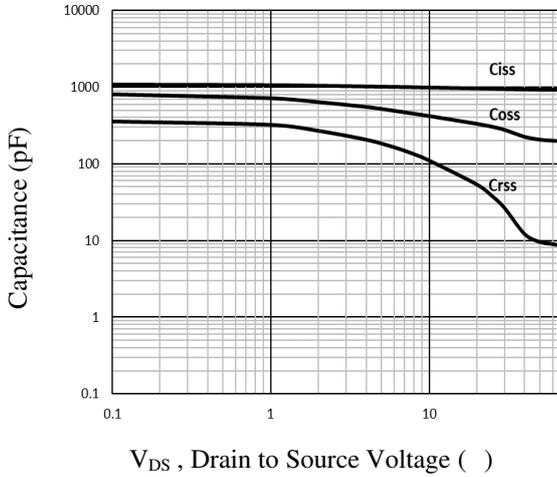


Fig.7 Capacitance Characteristics

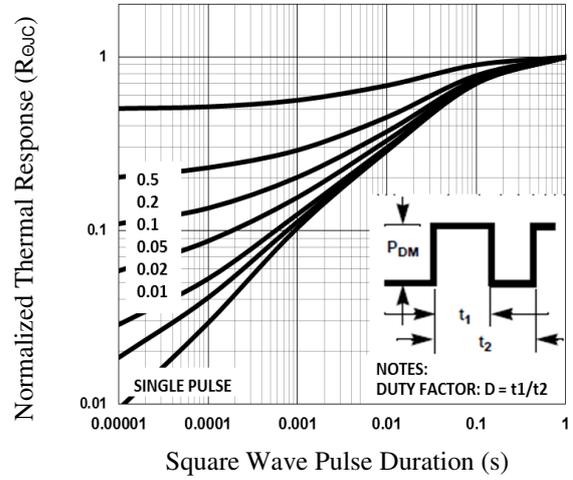


Fig.8 Normalized Transient Response

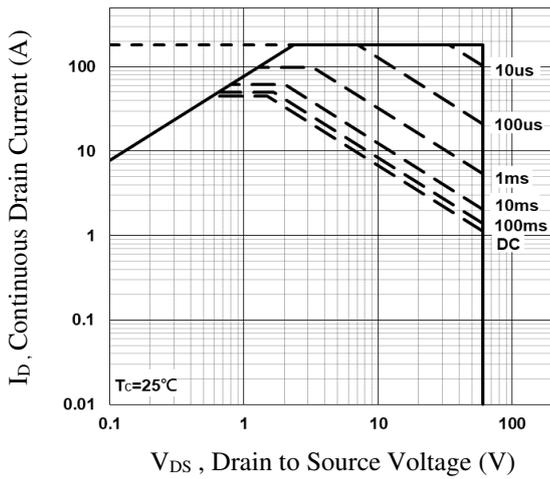


Fig.9 Maximum Safe Operation Area

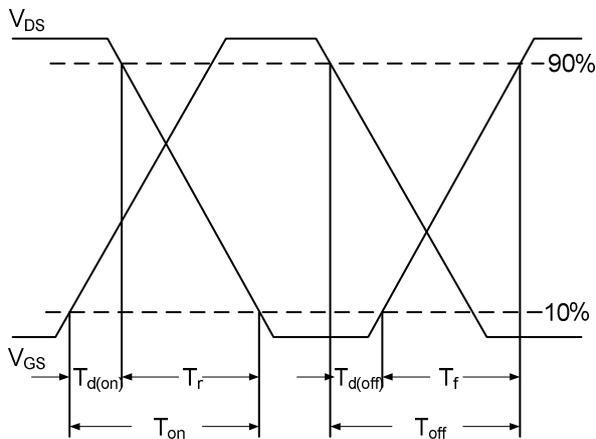


Fig.10 Switching Time Waveform

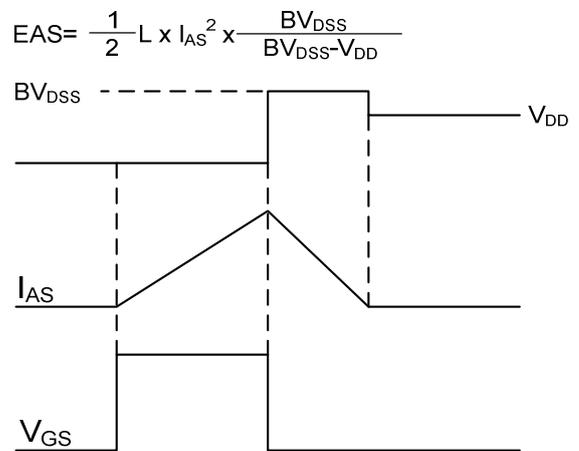
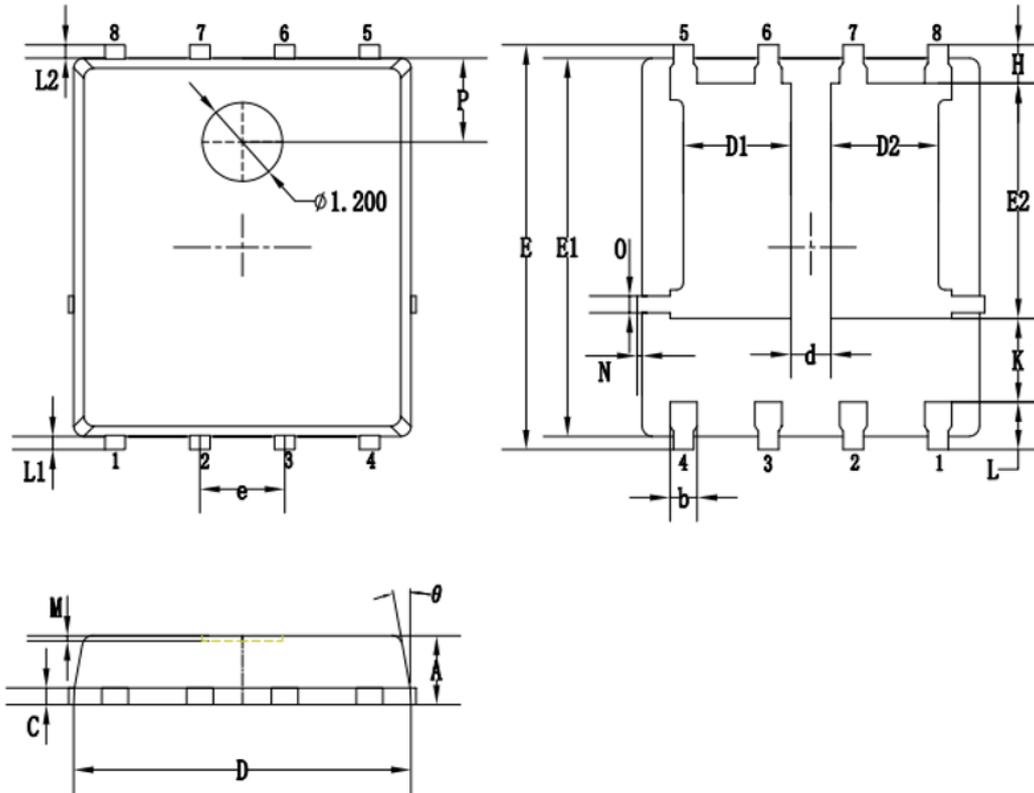


Fig.11 EAS Waveform

Packaging information


SYMBOLS	MILLIMETERS		
	MIN.	NOM.	MAX.
A	0.90	1.05	1.20
b	0.35	0.40	0.50
C	0.20	0.25	0.35
D	4.90	5.05	5.20
D1/D2	1.51	1.61	1.71
d	0.50	0.60	0.70
E	6.00	6.15	6.30
E1	5.60	5.75	5.90
E2	3.47	3.57	3.67
e	1.27 BSC.		
H	0.48	0.58	0.68
K	1.17	1.27	1.37
L	0.64	0.74	0.84
L1/L2	0.20 REF.		
θ	8°	10°	12°
M	0.08 REF.		
N	0	-	0.15
O	0.25 REF.		
P	1.28 REF.		

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